

TEST REPORT

Applicant: TCL Communication Ltd.
Address: 5/F, Building 22E, 22 Science Park East Avenue,
Hong Kong Science Park, Shatin, NT, Hong Kong
Equipment Type: Tablet PC
Model Name: 8189R (refer to section 2.3)
Brand Name: TCL
FCC ID: 2ACCJB233
Test Standard: 47 CFR Part 15 Subpart B
ANSI C63.4-2014
Sample Arrival Date: Dec. 10, 2025
Test Date: Dec. 15, 2025 - Dec. 16, 2025
Date of Issue: Jan. 12, 2026

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Qiu Yongjing**Checked by:** Zong Liyao**Approved by:** Tolan Tu
(Testing Director)

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Jan. 12, 2026</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☐ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☒ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ Building 2, Intelligent Connected Vehicle Industrial Park, No. 55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The certification body is American Association for Laboratory Accreditation (A2LA).

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	TCL Communication Ltd.
Address	5/F, Building 22E, 22 Science Park East Avenue, Hong Kong Science Park, Shatin, NT, Hong Kong

2.2 Manufacturer Information

Manufacturer	TCL Communication Ltd.
Address	5/F, Building 22E, 22 Science Park East Avenue, Hong Kong Science Park, Shatin, NT, Hong Kong

2.3 General Description for Equipment under Test (EUT)

EUT Name	Tablet PC
Model Name Under Test	8189R
Series Model Name	8189K
Description of Model name differentiation	All models are same with electrical parameters and internal circuit structure, but only differ in model name and Silkscreen; and the model of 8189K has some APKs for children. (this information provided by the applicant)
Hardware Version	N/A
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.4 Ancillary Equipment

Please refer the document “BL-SZ25B1320-AW EUT external photo.pdf”.

2.5 Technical Information

Network and Wireless connectivity	3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network LTE FDD Band 2/3/4/5/7/12/14/20/29/66 LTE CA: CA_4A-29A, CA_2A-5A, CA_4A-5A, CA_2A-12A, CA_2A-29A, CA_4A-12A, CA_5A-66A, CA_12A-66A, CA_2A-66A, CA_66A-66A, CA_29A-66A, CA_2A-14A, CA_14A-66A 5G Network SA: NR n2/5/12/14/66/77 NSA(EN-DC): DC_5A_n2A, DC_12A_n2A, DC_66A_n2A, DC_2A_n2A, DC_14A_n2A, DC_5A-66A_n2A, DC_2A_n5A, DC_66A_n5A, DC_2A-66A_n5A, DC_66A-66A_n5A, DC_2A-2A_n5A, DC_2A_n66A, DC_5A_n66A, DC_12A_n66A, DC_66A_n66A, DC_14A_n66A, DC_2A-66A_n66A, DC_2A_n77A, DC_5A_n77A, DC_66A_n77A, DC_12A_n77A, DC_14A_n77A, DC_2A-2A_n77A, DC_66A-66A_n77A, DC_2A-5A_n77A, DC_2A-66A_n77A, DC_5A-66A_n77A
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	Bluetooth (BR+EDR+BLE) WIFI 802.11a, 802.11b, 802.11g, 802.11n(HT20/40), 802.11ac(VHT20/40/80)
Classification of equipment	Class B
The highest internal frequency of EUT	5850 MHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Remark
1	Radiated Emission	15.109	Pass	--
2	Conducted Emission, AC Ports	15.107	Pass	--

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.2 dB
Radiated emissions (30 MHz-1 GHz)-966#2	4.4 dB
Radiated emissions (1 GHz-18 GHz)-966#2	5.0 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Enclosure List

Description	Manufacturer	Model	Serial No.	Length	Description	Use
Laptop	N/A	N/A	N/A	N/A	N/A	☒
Data connector	N/A	N/A	N/A	N/A	N/A	☒
USB disk	N/A	N/A	N/A	N/A	N/A	☒
TF Card	N/A	N/A	N/A	N/A	N/A	☒
Earphone	N/A	N/A	N/A	N/A	N/A	☒
Type-C Earphone	N/A	N/A	N/A	N/A	N/A	☒
Wireless Communications Test Set	R&S	CMW500	102318	N/A	Cal. Due 2026.05.27	☒
5G Comprehensive Tester	Keysight	E7515B	N/A	N/A	Cal. Due 2026.08.10	☒

4.2 Test Configurations

All test modes of EUT are listed in the table below.

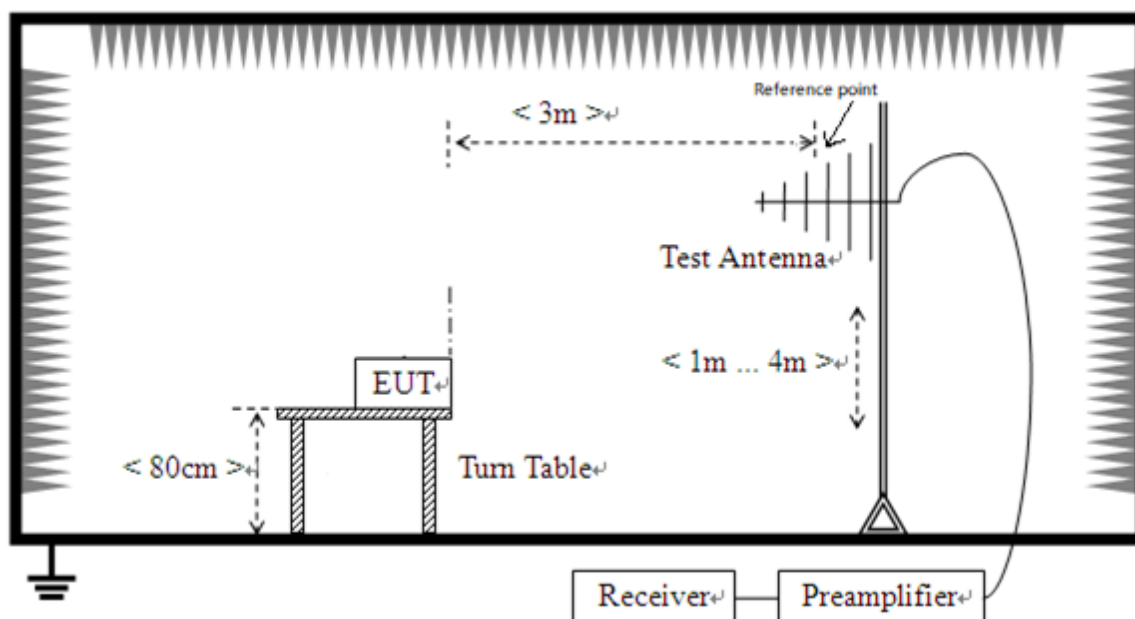
Test Mode Configuration	Description
Mode 1	<u>The Front Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 2	<u>The Rear Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 3	<u>The Video Play Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 4	<u>The Charging Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 5	<u>The USB Test Mode</u> EUT + USB Cable + Battery + Laptop + TF Card + Headset
Mode 6	<u>The OTG Test Mode</u> EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 7	<u>The WCDMA Band 5 RX Test Mode</u> WCDMA Band 5 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset

Mode 8	<u>The LTE Band 5 RX Test Mode</u> LTE Band 5 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 9	<u>The LTE Band 8 RX Test Mode</u> LTE Band 8 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 10	<u>The LTE Band 12 RX Test Mode</u> LTE Band 12 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 11	<u>The LTE Band 13 RX Test Mode</u> LTE Band 13 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 12	<u>The LTE Band 14 RX Test Mode</u> LTE Band 14 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 13	<u>The LTE Band 20 RX Test Mode</u> LTE Band 20 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 14	<u>The LTE Band 29 RX Test Mode</u> LTE Band 29 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 15	<u>The 5G NR n5 RX Test Mode</u> 5G NR n5 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 16	<u>The 5G NR n12 RX Test Mode</u> 5G NR n12 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset
Mode 17	<u>The 5G NR n14 RX Test Mode</u> 5G NR n14 RX + EUT + Battery + Data connector + USB Disk + TF Card + Headset

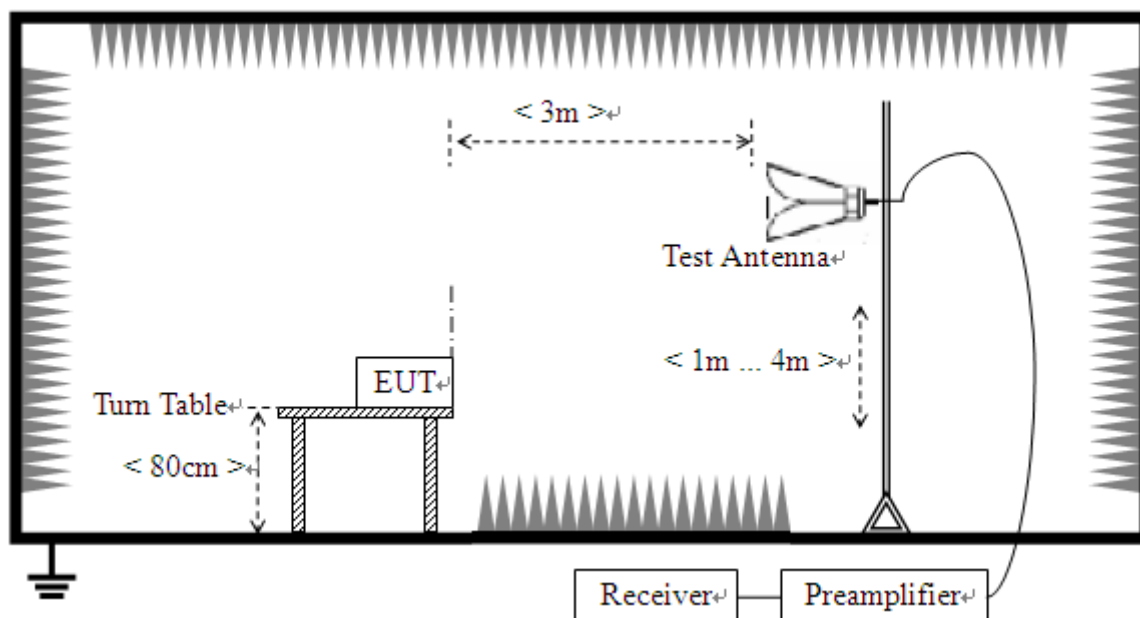
Test Case	Test Mode Configuration	Worst Mode
Radiated Emission	Mode 1~Mode 17	4
Conducted Emission, AC Ports	Mode 1~Mode 5	4
Note: All operation modes were tested, but only test data of the worst mode was presented in this report.		

4.3 Test Setups

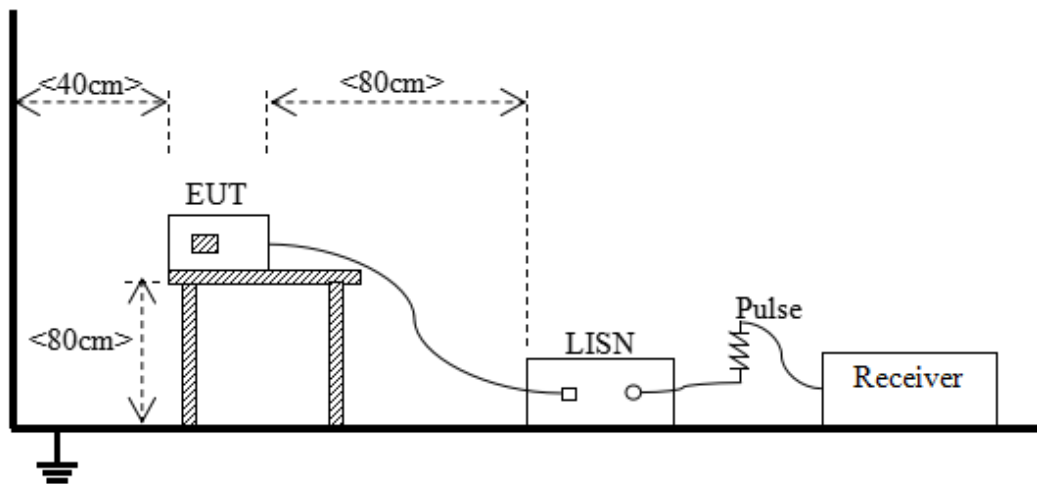
Test Setup 1



Radiated Emission (30 MHz-1 GHz)



Radiated Emission (above 1 GHz)

Test Setup 2

Conducted Emissions, AC Ports

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class A (at 3 m)
	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)
30 - 88	100	40	49.5
88 - 216	150	43.5	54
216 - 960	200	46	56.9
Above 960	500	54	60

NOTE:

- 1) Field Strength (dB $\mu\text{V/m}$) = $20 \cdot \log [\text{Field Strength } (\mu\text{V/m})]$.
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For 30 MHz to 1000 MHz, the CISPR quasi-peak is employed.

For above 1000 MHz, according to the requirements of FCC 15.35, unless otherwise specified, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency range (GHz)	Class B (at 3 m)			Class A (at 3 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)
1 - F_M	500	54	74	60	80

Note 1: The highest measurement frequency, F_M , in GHz, shall be determined as next Table.

Note 2: Average Class A limit at 3m L_{3m} is determined by the following conversion formula:

$$L_{3m} = L_{10m} + 20 \cdot \log(d_{10m}/d_{3m})$$

Where:

L_{3m} is Average Class A limit at 3m;

L_{10m} is Average Class A limit at 10m;

d_{10m} is Measurement distance in 10m;

d_{3m} is Measurement distance in 3m.

For this case: $L_{3m} = 49.5 + 20 \cdot \log(10/3) = 60$ (dB $\mu\text{V/m}$).

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108 \text{ MHz}$	1 GHz
$108 \text{ MHz} \leq F_X \leq 500 \text{ MHz}$	2 GHz
$500 \text{ MHz} \leq F_X \leq 1 \text{ GHz}$	5 GHz
$F_X \geq 1 \text{ GHz}$	$5 * F_X$ or 40 GHz, whichever is lower.
Note: F_X is Highest frequency generated or used in the device or on which the device operates or tunes.	

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Radiated Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360° , and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1 \text{ GHz}$, 100 kHz for $f < 1 \text{ GHz}$

VBW $\geq$ RBW

Sweep = auto

Detector function = peak for $f < 1 \text{ GHz}$, peak & RMS Average for $f \geq 1 \text{ GHz}$

Trace = max hold

5.1.1.4 Test Result and Test Equipment List

Please refer to ANNEX A.1.

NOTE:

1. Results (dB μ V/m) = Reading (dB μ V) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Margin = Limit - Results

5.1.2 Conducted Emission, AC Ports

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 2) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW $\geq$ RBW

Sweep = 10ms

Detector function = peak & Average

Trace = max hold

5.1.2.4 Test Result and Test Equipment List

Please refer to ANNEX A.2.

NOTE:

1. Results (dB μ V) = Reading (dB μ V) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Margin = Limit - Results

ANNEX A TEST RESULTS

A.1 Radiated Emission

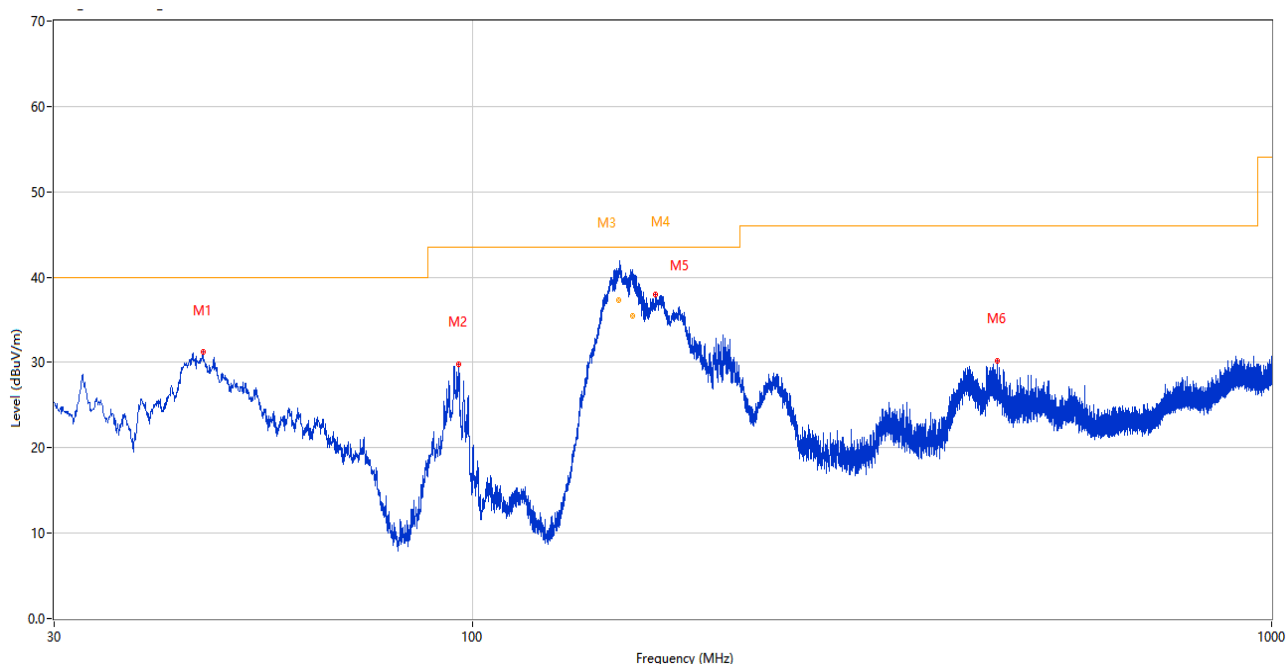
Note 1: The symbol of "--" in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Sample No.	S14	Temperature	21.8℃
Humidity	48%RH	Pressure	101kPa
Test Engineer	Zhong Pingqi	Test Date	2025.12.15

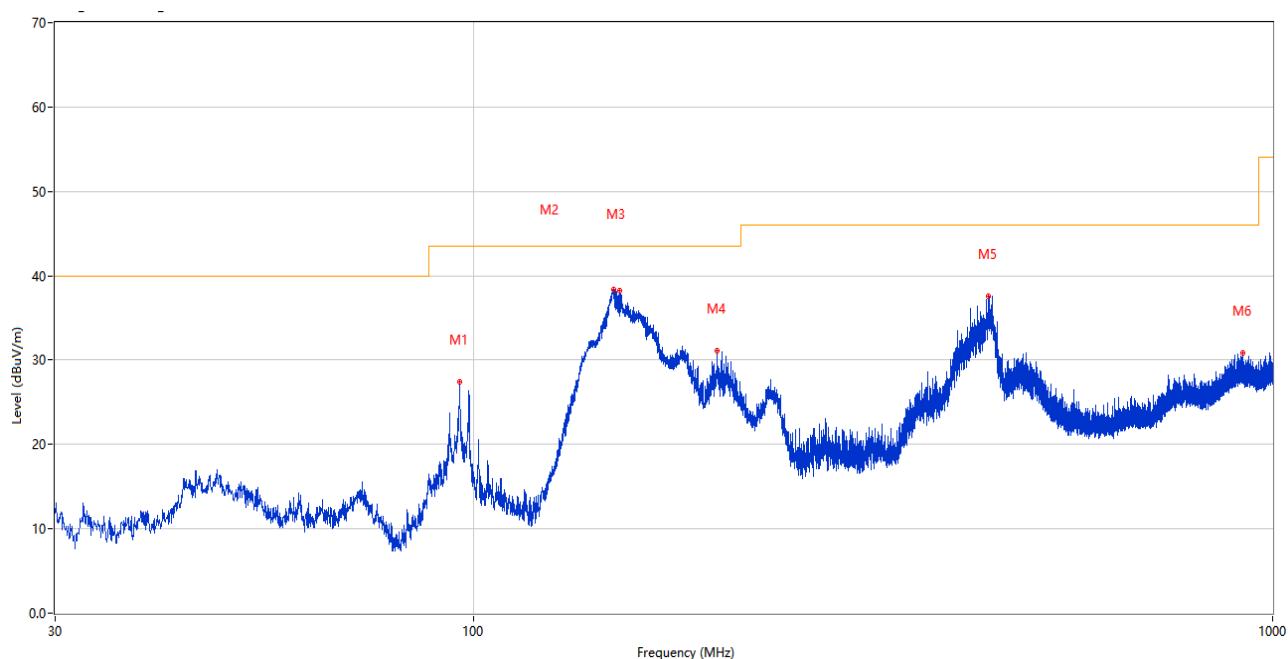
Test Mode 4

1) Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	46.053	31.18	-26.47	40.0	8.82	Peak	0.00	100	Vertical	Pass
2	96.202	29.81	-26.67	43.5	13.69	Peak	336.00	100	Vertical	Pass
3	152.562	40.35	-29.62	43.5	3.15	Peak	357.00	101	Vertical	N/A
3*	152.562	37.37	-29.62	43.5	6.13	QP	357.00	101	Vertical	Pass
4	158.729	38.27	-29.48	43.5	5.23	Peak	359.00	100	Vertical	N/A
4*	158.729	35.43	-29.48	43.5	8.07	QP	359.00	100	Vertical	Pass
5	169.534	37.92	-28.44	43.5	5.58	Peak	353.00	100	Vertical	Pass
6	454.181	30.15	-19.60	46.0	15.85	Peak	237.00	100	Vertical	Pass

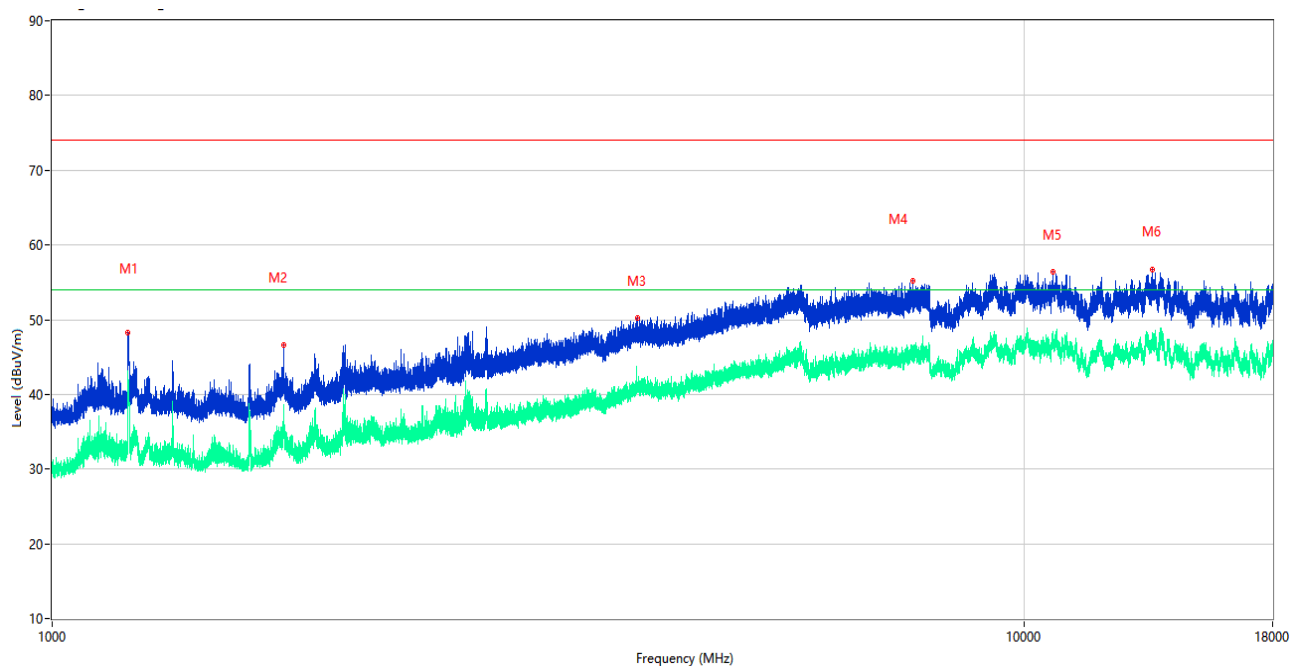
2) Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	96.202	27.46	-26.67	43.5	16.04	Peak	70.00	200	Horizontal	Pass
2	149.698	38.34	-29.90	43.5	5.16	Peak	4.00	200	Horizontal	Pass
3	152.511	38.20	-29.90	43.5	5.30	Peak	0.00	200	Horizontal	Pass
4	201.884	31.08	-26.32	43.5	12.42	Peak	234.00	100	Horizontal	Pass
5	440.940	37.60	-19.75	46.0	8.40	Peak	46.00	200	Horizontal	Pass
6	918.375	30.81	-8.60	46.0	15.19	Peak	252.00	100	Horizontal	Pass

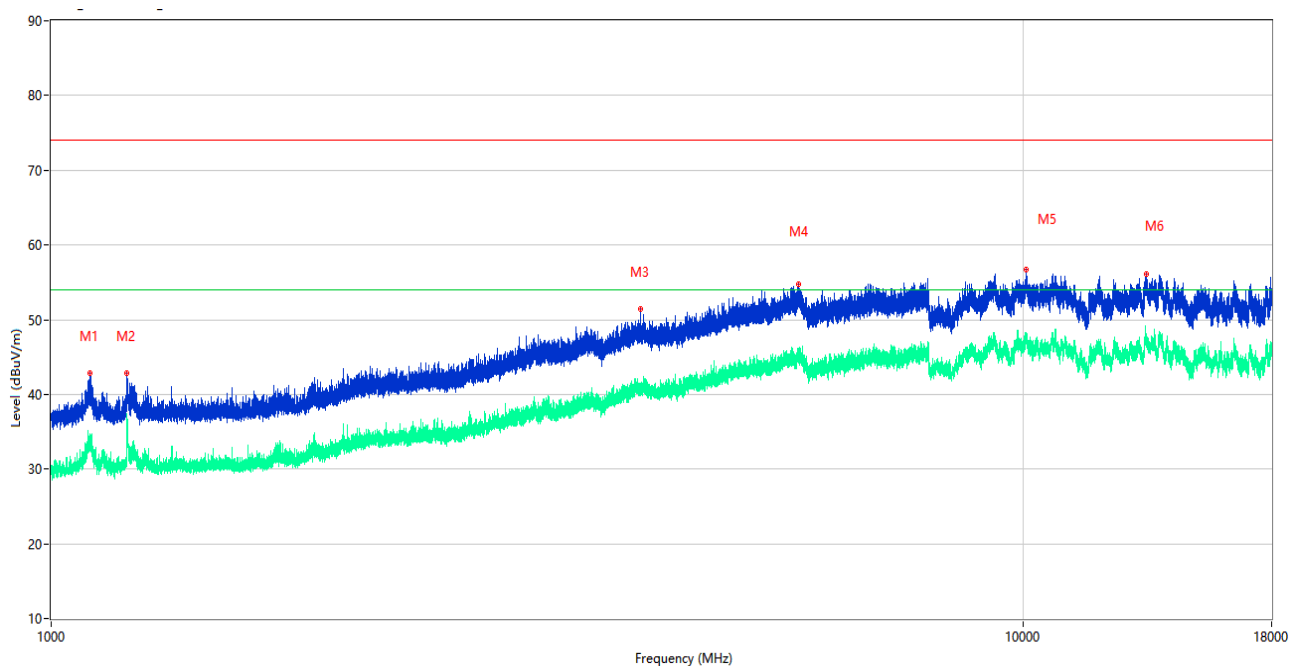
Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Below 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.04.16	2026.04.15	☒
Test Antenna-Bi-Log	SCHWARZB ECK	VULB 9163	01414	2023.11.03	2026.11.02	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

3) Test Antenna Vertical, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1196.040	48.27	-15.57	74.0	25.73	Peak	213.00	100	Vertical	Pass
1**	1196.040	41.35	-15.57	54.0	12.65	AV	213.00	100	Vertical	Pass
2	1730.340	46.64	-15.37	74.0	27.36	Peak	231.00	100	Vertical	Pass
2**	1730.340	35.21	-15.37	54.0	18.79	AV	231.00	100	Vertical	Pass
3	4000.620	50.23	-1.81	74.0	23.77	Peak	206.00	100	Vertical	Pass
3**	4000.620	40.65	-1.81	54.0	13.35	AV	206.00	100	Vertical	Pass
4	7677.920	55.27	1.68	74.0	18.73	Peak	121.00	100	Vertical	Pass
4**	7677.920	45.42	1.68	54.0	8.58	AV	121.00	100	Vertical	Pass
5	10709.000	56.40	3.74	74.0	17.60	Peak	131.00	100	Vertical	Pass
5**	10709.000	47.07	3.74	54.0	6.93	AV	131.00	100	Vertical	Pass
6	13551.000	56.76	4.64	74.0	17.24	Peak	211.00	100	Vertical	Pass
6**	13551.000	46.68	4.64	54.0	7.32	AV	211.00	100	Vertical	Pass

4) Test Antenna Horizontal, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1095.030	42.79	-15.70	74.0	31.21	Peak	75.00	100	Horizontal	Pass
1**	1095.030	34.65	-15.70	54.0	19.35	AV	75.00	100	Horizontal	Pass
2	1195.780	42.78	-15.60	74.0	31.22	Peak	129.00	100	Horizontal	Pass
2**	1195.780	35.40	-15.60	54.0	18.60	AV	129.00	100	Horizontal	Pass
3	4038.460	51.36	-2.31	74.0	22.64	Peak	337.00	100	Horizontal	Pass
3**	4038.460	41.09	-2.31	54.0	12.91	AV	337.00	100	Horizontal	Pass
4	5874.140	54.68	2.91	74.0	19.32	Peak	25.00	100	Horizontal	Pass
4**	5874.140	44.54	2.91	54.0	9.46	AV	25.00	100	Horizontal	Pass
5	10068.500	56.64	4.87	74.0	17.36	Peak	360.00	100	Horizontal	Pass
5**	10068.500	47.18	4.87	54.0	6.82	AV	360.00	100	Horizontal	Pass
6	13384.500	56.09	4.89	74.0	17.91	Peak	119.00	100	Horizontal	Pass
6**	13384.500	47.42	4.89	54.0	6.58	AV	119.00	100	Horizontal	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Above 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.04.16	2026.04.15	☒
Test Antenna-Horn	SCHWARZB ECK	BBHA 9120D	02459	2023.10.26	2026.10.25	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

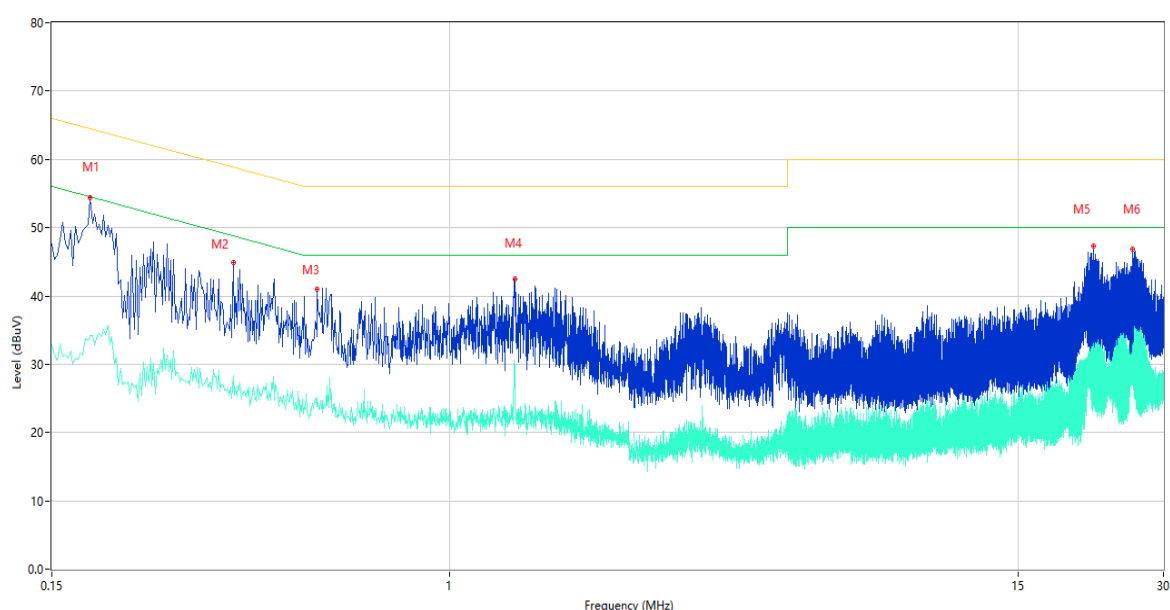
A.2 Conducted Emission, AC Ports

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Sample No.	S14	Temperature	22.1℃
Humidity	48%RH	Pressure	101kPa
Test Engineer	Hua Bin	Test Date	2025.12.15

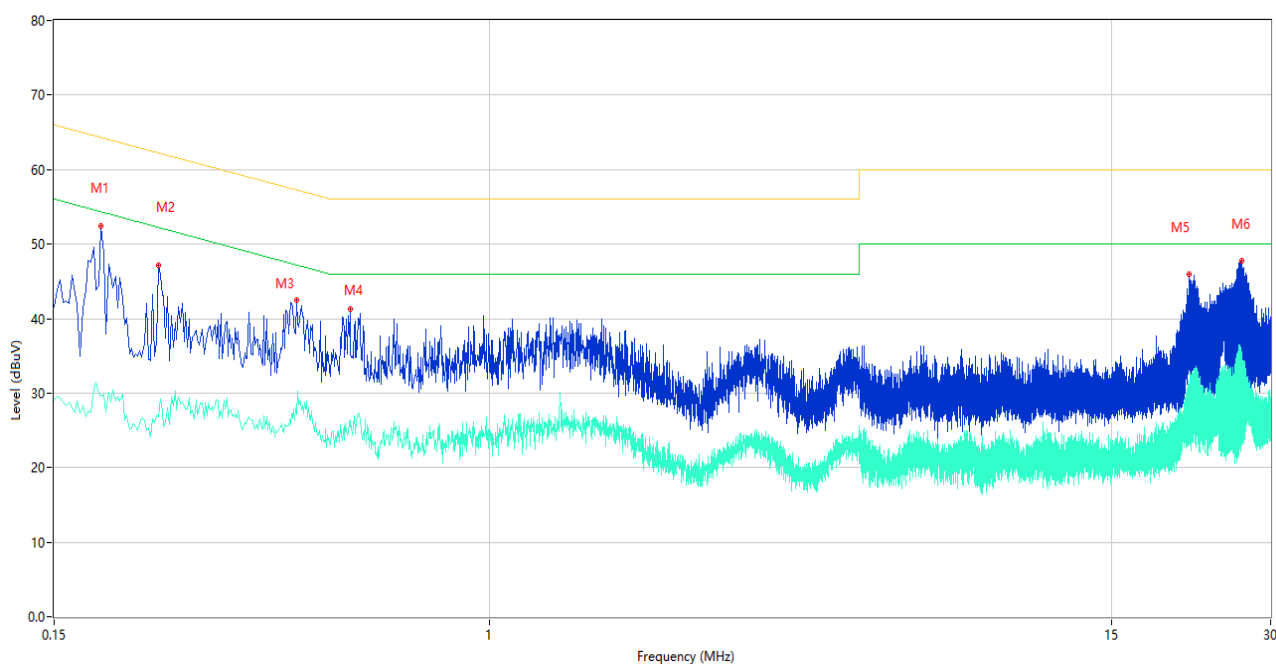
Test Mode 4

1) AC Ports - L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.180	54.46	10.28	64.49	10.03	Peak	L	Pass
1**	0.180	34.22	10.28	54.49	20.27	AV	L	Pass
2	0.356	44.84	10.26	58.82	13.98	Peak	L	Pass
2**	0.356	28.38	10.26	48.82	20.44	AV	L	Pass
3	0.532	40.91	10.28	56.00	15.09	Peak	L	Pass
3**	0.532	25.23	10.28	46.00	20.77	AV	L	Pass
4	1.364	42.49	10.37	56.00	13.51	Peak	L	Pass
4**	1.364	26.82	10.37	46.00	19.18	AV	L	Pass
5	21.532	47.26	14.73	60.00	12.74	Peak	L	Pass
5**	21.532	31.46	14.73	50.00	18.54	AV	L	Pass
6	25.840	46.90	15.60	60.00	13.10	Peak	L	Pass
6**	25.840	31.88	15.60	50.00	18.12	AV	L	Pass

2) AC Ports - N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.184	52.36	10.20	64.30	11.94	Peak	N	Pass
1**	0.184	29.52	10.20	54.30	24.78	AV	N	Pass
2	0.236	47.12	10.18	62.24	15.12	Peak	N	Pass
2**	0.236	26.77	10.18	52.24	25.47	AV	N	Pass
3	0.432	42.44	10.19	57.21	14.77	Peak	N	Pass
3**	0.432	27.10	10.19	47.21	20.11	AV	N	Pass
4	0.544	41.21	10.20	56.00	14.79	Peak	N	Pass
4**	0.544	26.31	10.20	46.00	19.69	AV	N	Pass
5	21.028	45.91	14.68	60.00	14.09	Peak	N	Pass
5**	21.028	23.49	14.68	50.00	26.51	AV	N	Pass
6	26.496	47.80	15.77	60.00	12.20	Peak	N	Pass
6**	26.496	34.03	15.77	50.00	15.97	AV	N	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038B	MY61380132	2025.04.01	2026.03.31	☒
LISN	SCHWARZBECK	NSLK 8127	01009	2025.07.15	2026.07.14	☒
Shielded Room	YiHeng Electronic Co., Ltd	/	235	2024.11.05	2027.11.04	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ25B1320-AE.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-SZ25B1320-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-SZ25B1320-AI.PDF”.

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--END OF REPORT--